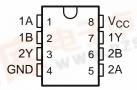
SN74AUC2G00 DUAL 2-INPUT POSITIVE-NAND GATE

SCES440A-MAY 2003-REVISED MARCH 2005

FEATURES

- Available in the Texas Instruments
 NanoStar™ and NanoFree™ Packages
- Optimized for 1.8-V Operation and Is 3.6-V I/O Tolerant to Support Mixed-Mode Signal Operation
- I_{off} Supports Partial-Power-Down Mode Operation
- Sub-1-V Operable
- Max t_{pd} of 1.2 ns at 1.8 V
- Low Power Consumption, 10 μA at 1.8 V
- ±8-mA Output Drive at 1.8 V
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)

DCT OR DCU PACKAGE (TOP VIEW)



YEP OR YZP PACKAGE (BOTTOM VIEW)

SND	04	50	2A
2Y	○ 3	60	2B
1B	03 02	70	1Y
1A	01	80	Vcc

DESCRIPTION/ORDERING INFORMATION

This dual 2-input positive-NAND gate is operational at 0.8-V to 2.7-V V_{CC} , but is designed specifically for 1.65-V to 1.95-V V_{CC} operation.

The SN74AUC2G00 performs the Boolean function $Y = \overline{A \cdot B}$ or $Y = \overline{A} + \overline{B}$ in positive logic.

NanoStar™ and NanoFree™ package technology is a major breakthrough in IC packaging concepts, using the die as the package.

This device is fully specified for partial-power-down applications using I_{off} . The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

ORDERING INFORMATION

T _A	PACKAGE ⁽¹⁾	C	ORDERABLE PART NUMBER	TOP-SIDE MARKING(2	
-	NanoStar™ – WCSP (DSBGA) 0.23-mm Large Bump – YEP	Tape and reel	SN74AUC2G00YEPR		
–40°C to 85°C	NanoFree™ – WCSP (DSBGA) 0.23-mm Large Bump – YZP (Pb-free)	Tape and reel	SN74AUC2G00YZPR	UA_	
	SSOP - DCT	Tape and reel	SN74AUC2G00DCTR	U00_	
	VSSOP - DCU	Tape and reel	SN74AUC2G00DCUR	U00_	

- (1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.
- (2) DCT: The actual top-side marking has three additional characters that designate the year, month, and assembly/test site. DCU: The actual top-side marking has one additional character that designates the assembly/test site. YEP/YZP: The actual top-side marking has three preceding characters to denote year, month, and sequence code, and one following character to designate the assembly/test site.

PDFlease be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

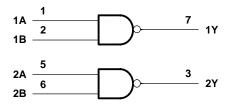
NanoFree are trademarks of Texas Instruments.



FUNCTION TABLE (EACH GATE)

INP	UTS	OUTPUT
Α	В	Y
Н	Н	L
L	X	Н
Х	L	Н

LOGIC DIAGRAM (POSITIVE LOGIC)



Absolute Maximum Ratings(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{CC}	Supply voltage range		-0.5	3.6	V
V_{I}	Input voltage range ⁽²⁾	Input voltage range ⁽²⁾			V
Vo	Voltage range applied to any output in the h	Voltage range applied to any output in the high-impedance or power-off state (2)		3.6	V
Vo	Output voltage range ⁽²⁾			V _{CC} + 0.5	V
I _{IK}	Input clamp current	V _I < 0		-50	mA
I _{OK}	Output clamp current $V_O < 0$			-50	mA
lo	Continuous output current	·		±20	mA
	Continuous current through V _{CC} or GND			±100	mA
		DCT package		220	
θ_{JA}	Package thermal impedance (3)	DCU package		227	°C/W
		YEP/YZP package		102	
T _{stg}	Storage temperature range		-65	150	°C

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

⁽²⁾ The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

⁽³⁾ The package thermal impedance is calculated in accordance with JESD 51-7.



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Recommended Operating Conditions⁽¹⁾

			MIN	MAX	UNIT	
V _{CC}	Supply voltage		0.8	2.7	V	
		$V_{CC} = 0.8 \text{ V}$				
V_{IH}	High-level input voltage	V _{CC} = 1.1 V to 1.95 V	$0.65 \times V_{CC}$		V	
		V _{CC} = 2.3 V to 2.7 V	1.7			
		V _{CC} = 0.8 V		0		
V_{IL}	Low-level input voltage	V _{CC} = 1.1 V to 1.95 V		$0.35 \times V_{CC}$	V	
		V _{CC} = 2.3 V to 2.7 V		0.7		
VI	Input voltage	,	0	3.6	V	
Vo	Output voltage		0	V_{CC}	V	
	High-level output current	V _{CC} = 0.8 V		-0.7		
		V _{CC} = 1.1 V		-3		
I_{OH}		V _{CC} = 1.4 V		-5	-5 mA	
		V _{CC} = 1.65 V		-8		
		V _{CC} = 2.3 V		-9		
		V _{CC} = 0.8 V		0.7		
		V _{CC} = 1.1 V		3		
I_{OL}	Low-level output current	V _{CC} = 1.4 V		5	mA	
		V _{CC} = 1.65 V		8		
		V _{CC} = 2.3 V		9		
Δt/Δν	Input transition rise or fall rate	·		20	ns/V	
T _A	Operating free-air temperature		-40	85	°C	

⁽¹⁾ All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

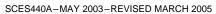
Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PAF	RAMETER	TEST CONDITIONS	V _{cc}	MIN TYP(1)	MAX	UNIT	
		$I_{OH} = -100 \mu\text{A}$	0.8 V to 2.7 V	V _{CC} – 0.1			
		$I_{OH} = -0.7 \text{ mA}$	0.8 V	0.55			
V _{OH}	$I_{OH} = -3 \text{ mA}$	1.1 V	0.8		V		
VOH		$I_{OH} = -5 \text{ mA}$	1.4 V	1		V	
		$I_{OH} = -8 \text{ mA}$	1.65 V	1.2			
		$I_{OH} = -9 \text{ mA}$	2.3 V	1.8			
		$I_{OL} = 100 \mu A$	0.8 V to 2.7 V		0.2		
		$I_{OL} = 0.7 \text{ mA}$	0.8 V	0.25		V	
\/		I _{OL} = 3 mA	1.1 V		0.3		
V _{OL}		I _{OL} = 5 mA	1.4 V		0.4	V	
		$I_{OL} = 8 \text{ mA}$	1.65 V		0.45		
		I _{OL} = 9 mA	2.3 V		0.6		
I	A or B inputs	$V_I = V_{CC}$ or GND	0 to 2.7 V		±5	μΑ	
I _{off}		V_1 or $V_0 = 2.7 \text{ V}$	0	_	±10	μΑ	
I _{CC}	·	$V_I = V_{CC}$ or GND, $I_O = 0$	0.8 V to 2.7 V	·	10	μΑ	
Ci		$V_I = V_{CC}$ or GND	2.5 V	2.5		pF	

⁽¹⁾ All typical values are at $T_A = 25$ °C.

SN74AUC2G00 DUAL 2-INPUT POSITIVE-NAND GATE





Switching Characteristics

over recommended operating free-air temperature range, $C_L = 15 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM TO (INPUT) (OUTPU	TO (OUTPUT)	$V_{CC} = 0.8 \text{ V}$ $V_{CC} = 1.2 \text{ V}$ $\pm 0.1 \text{ V}$			V _{CC} = 1.5 V ± 0.1 V		V _{CC} = 1.8 V ± 0.15 V		V _{CC} = 2.5 V ± 0.2 V		UNIT	
	(INPOT)	(001F01)	TYP	MIN	MAX	MIN	MAX	MIN	TYP	TYP MAX	MIN	MAX	
t _{pd}	A or B	Υ	8	1	2.5	0.8	1.6	0.6	0.9	1.2	0.5	1	ns

Switching Characteristics

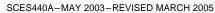
over recommended operating free-air temperature range, $C_L = 30 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)		V_{CC} = 1.8 V \pm 0.15 V			2.5 V 2 V	UNIT
	(INFOI)	(001701)	MIN	TYP	MAX	MIN	MAX	
t _{pd}	A or B	Υ	1.2	1.6	2.1	1	1.7	ns

Operating Characteristics

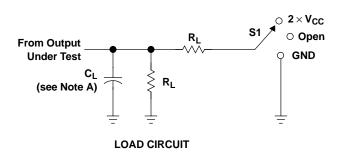
 $T_A = 25^{\circ}C$

/ \								
	PARAMETER	TEST	V _{CC} = 0.8 V	V _{CC} = 1.2 V	V _{CC} = 1.5 V	V _{CC} = 1.8 V	V _{CC} = 2.5 V	UNIT
	FARAMETER	CONDITIONS TY		TYP	TYP	TYP	TYP	ONII
C _{pd}	Power dissipation capacitance	f = 10 MHz	12	12	12	12	13	pF



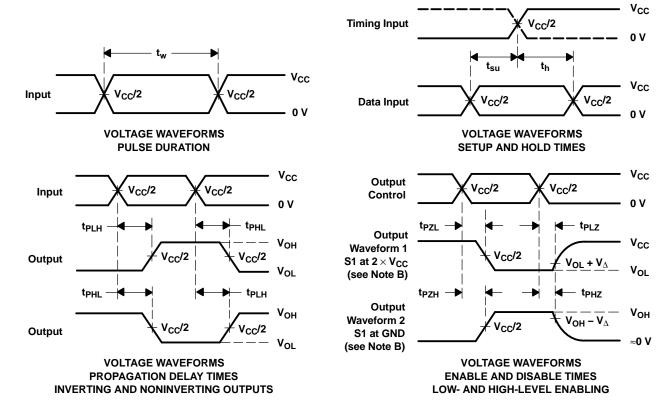


PARAMETER MEASUREMENT INFORMATION



TEST	S1
t _{PLH} /t _{PHL}	Open
t _{PLZ} /t _{PZL}	2×V _{CC}
t _{PHZ} /t _{PZH}	GND

CL	R_{L}	$oldsymbol{V}_\Delta$
15 pF	2 k Ω	0.1 V
15 pF	2 k Ω	0.1 V
15 pF	2 k Ω	0.1 V
15 pF	2 k Ω	0.15 V
15 pF	2 k Ω	0.15 V
30 pF	1 k Ω	0.15 V
30 pF	500 Ω	0.15 V
	15 pF 15 pF 15 pF 15 pF 15 pF 30 pF	15 pF 2 kΩ 15 pF 2 kΩ 30 pF 1 kΩ



- NOTES: A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_{Ω} = 50 Ω , slew rate \geq 1 V/ns.
 - D. The outputs are measured one at a time, with one transition per measurement.
 - E. t_{PLZ} and t_{PHZ} are the same as t_{dis}.
 - F. t_{PZL} and t_{PZH} are the same as t_{en} .
 - G. t_{PLH} and t_{PHL} are the same as t_{pd}.
 - H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms



PACKAGE OPTION ADDENDUM

6-Jun-2005

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
SN74AUC2G00DCTR	ACTIVE	SM8	DCT	8	3000	Pb-Free (RoHS)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUC2G00DCUR	ACTIVE	US8	DCU	8	3000	Pb-Free (RoHS)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUC2G00DCURE4	ACTIVE	US8	DCU	8	3000	Pb-Free (RoHS)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUC2G00YEPR	ACTIVE	WCSP	YEP	8	3000	TBD	SNPB	Level-1-260C-UNLIM
SN74AUC2G00YZPR	ACTIVE	WCSP	YZP	8	3000	Pb-Free (RoHS)	SNAGCU	Level-1-260C-UNLIM

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

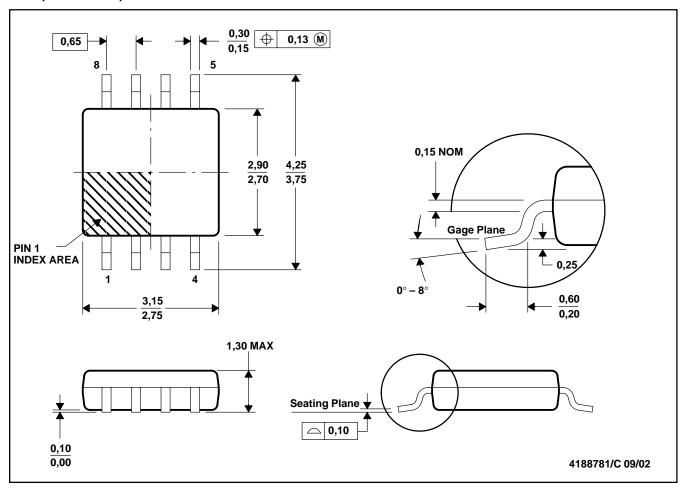
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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DCT (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE

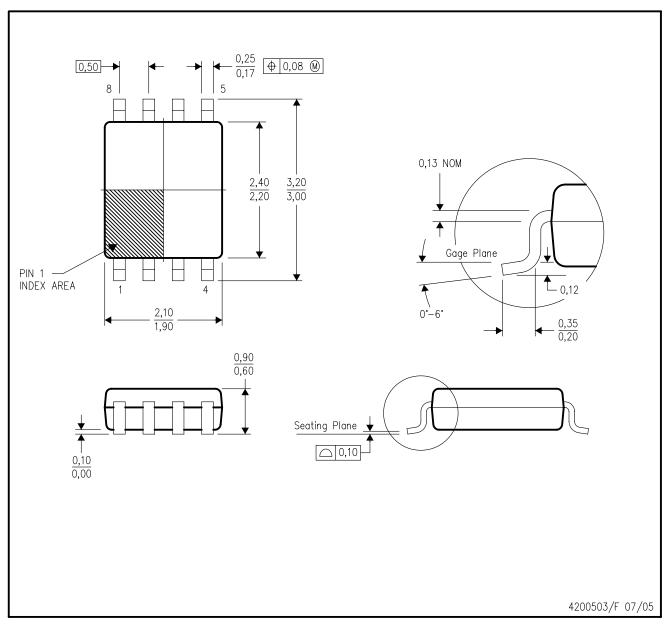


NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.C. Body dimensions do not include mold flash or protrusion
- D. Falls within JEDEC MO-187 variation DA.

DCU (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE (DIE DOWN)



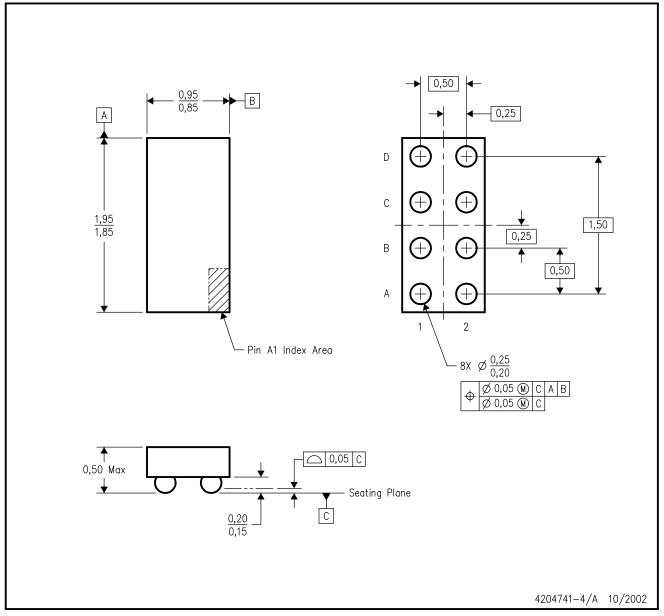
NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Falls within JEDEC MO-187 variation CA.



YZP (R-XBGA-N8)

DIE-SIZE BALL GRID ARRAY



NOTES:

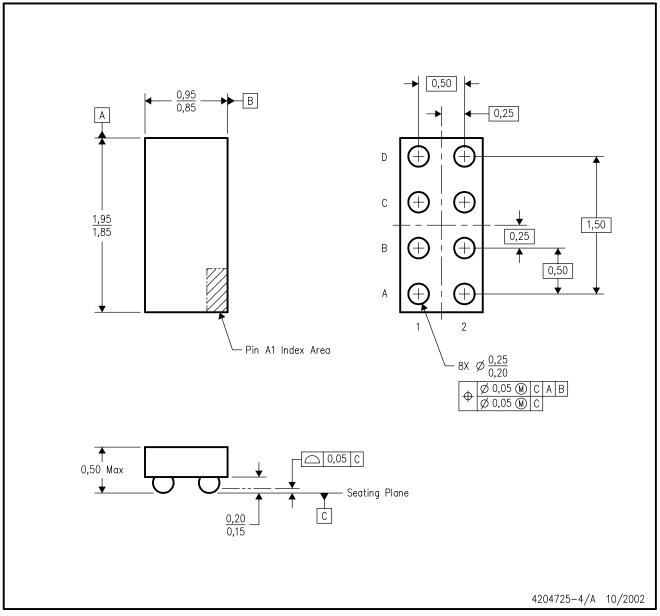
- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. NanoFree™ package configuration.
- D. This package is lead—free. Refer to the 8 YEP package (drawing 4204725) for tin—lead (SnPb).

NanoFree is a trademark of Texas Instruments.



YEP (R-XBGA-N8)

DIE-SIZE BALL GRID ARRAY



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. NanoStar™ package configuration.
- D. This package is tin-lead (SnPb). Refer to the 8 YZP package (drawing 4204741) for lead-free.

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Post Office Box 655303 Dallas, Texas 75265